

# **ECOSPARK® 2 Ignition IGBT**

300 mJ, 400 V, N-Channel Ignition IGBT

## FGD3040G2-F085C FGB3040G2-F085C

#### **Features**

- SCIS Energy = 300 mJ at  $T_J = 25$ °C
- Logic Level Gate Drive
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

#### **Applications**

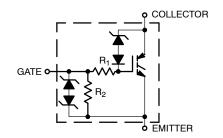
- Automotive Ignition Coil Driver Circuits
- High Current Ignition System
- Coil on Plug Application

#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Symbol	Parameter	Value	Unit
BV <sub>CER</sub>	Collector to Emitter Breakdown Voltage (IC = 1 mA)	400	V
BV <sub>ECS</sub>	Emitter to Collector Voltage - Reverse Battery Condition (IC = 10 mA)	28	V
E <sub>SCIS25</sub>	ISCIS = 14.2 A, L = 3.0 mHy, RGE = 1 K $\Omega$ , T $_{\rm C}$ = 25°C (Note 1)	300	mJ
E <sub>SCIS150</sub>	ISCIS = 10.8 A, L = 3.0 mHy, RGE = 1 K $\Omega$ , T $_{\rm C}$ = 150°C (Note 2)	170	mJ
IC25	Collector Current Continuous at VGE = 5.0 V, T <sub>C</sub> = 25°C	41	А
IC110	Collector Current Continuous at VGE = 5.0 V, T <sub>C</sub> = 110°C	25.6	А
$V_{GEM}$	Gate to Emitter Voltage Continuous	±10	V
PD	Power Dissipation Total, T <sub>C</sub> = 25°C	150	W
	Power Dissipation Derating, $T_C > 25^{\circ}C$	1	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating Junction and Storage Temperature	-55 to +175	°C
TL	Lead Temperature for Soldering Purposes (1/8" from case for 10 s)	300	°C
T <sub>PKG</sub>	Reflow Soldering according to JESD020C	260	°C
ESD	HBM–Electrostatic Discharge Voltage at 100 pF, 1500 $\Omega$	4	kV
	CDM–Electrostatic Discharge Voltage at 1 $\Omega$	2	kV

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- Self clamped inductive Switching Energy (ESCIS25) of 300 mJ is based on the test conditions that is starting T<sub>J</sub> = 25°C, L = 3 mHy, ISCIS = 14.2 A, VCC = 100 V during inductor charging and VCC = 0 V during time in clamp.
- Self Clamped inductive Switching Energy (ESCIS150) of 170 mJ is based on the test conditions that is starting T<sub>J</sub> = 150°C, L = 3mHy, ISCIS = 10.8 A, VCC = 100 V during inductor charging and VCC = 0 V during time in clamp.



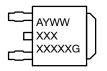




DPAK3 CASE 369AS

D<sup>2</sup>PAK-3 CASE 418AJ

#### **MARKING DIAGRAM**



A = Assembly Location

Y = Year

WW = Work Week

XXXX = Device Code

G = Pb-Free Package

#### ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

#### THERMAL RESISTANCE RATINGS

Characteristic	Symbol	Max	Units
Junction-to-Case - Steady State (Drain)		1	°C/W

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Symbol	Parameter	Test Conditions		Min	Тур.	Max.	Units
OFF CHARA	ACTERISTICS						
BV <sub>CER</sub>	Collector to Emitter Breakdown Voltage	$I_{CE} = 2 \text{ mA}, V_{GE} = 0 \text{ V},$ $R_{GE} = 1 \text{ k}\Omega,$ $T_{J} = -40 \text{ to } 150 ^{\circ}\text{C}$		370	400	430	V
BV <sub>CES</sub>	Collector to Emitter Breakdown Voltage	$I_{CE}$ = 10 mA, $V_{GE}$ = 0 V, $R_{GE}$ = 0, $T_{J}$ = -40 to 150°C		390	420	450	V
BV <sub>ECS</sub>	Emitter to Collector Breakdown Voltage	$I_{CE} = -75 \text{ mA}, V_{GE} = 0 \text{ V},$ $T_{J} = 25^{\circ}\text{C}$		28	-	-	V
BV <sub>GES</sub>	Gate to Emitter Breakdown Voltage	$I_{GES} = \pm 2 \text{ mA}$		±12	±14	_	V
I <sub>CER</sub>	Collector to Emitter Leakage Current	V <sub>CE</sub> = 175 V	T <sub>J</sub> = 25°C	-	-	25	μΑ
		$R_{GE} = 1 \text{ k}\Omega$	T <sub>J</sub> = 150°C	-	-	1	mA
I <sub>ECS</sub>	Emitter to Collector Leakage Current	V <sub>EC</sub> = 24 V	T <sub>J</sub> = 25°C	-	-	1	mA
			T <sub>J</sub> = 150°C	-	-	40	1
R <sub>1</sub>	Series Gate Resistance		•	-	120	-	Ω
R <sub>2</sub>	Gate to Emitter Resistance			10K	-	30K	Ω
ON CHARAC	CTERISTICS						
V <sub>CE(SAT)</sub>	Collector to Emitter Saturation Voltage	I <sub>CE</sub> = 6 A, V <sub>GE</sub> = 4 V, T <sub>J</sub> = 25°C		-	1.15	1.25	V
V <sub>CE(SAT)</sub>	Collector to Emitter Saturation Voltage	I <sub>CE</sub> = 10 A, V <sub>GE</sub> = 4.5 V, T <sub>J</sub> = 150°C		-	1.35	1.50	V
V <sub>CE(SAT)</sub>	Collector to Emitter Saturation Voltage	I <sub>CE</sub> = 15 A, V <sub>GE</sub> = 5 V, T <sub>J</sub> = 150°C		=	1.68	1.85	V
OYNAMIC C	HARACTERISTICS					•	
Q <sub>G(ON)</sub>	Gate Charge	I <sub>CE</sub> = 10 A, V <sub>CE</sub>	= 12 V, V <sub>GE</sub> = 5 V	-	21	-	nC
V <sub>GE(TH)</sub>	Gate to Emitter Threshold Voltage	I <sub>CE</sub> = 1 mA	T <sub>J</sub> = 25°C	1.3	1.5	2.2	V
		V <sub>CE</sub> = V <sub>GE</sub>	T <sub>J</sub> = 150°C	0.75	1.2	1.8	
$V_{GEP}$	Gate to Emitter Plateau Voltage	V <sub>CE</sub> = 12 V, I <sub>CE</sub> =	= 10 A	-	2.8	_	V
WITCHING	CHARACTERISTICS						
td <sub>(ON)R</sub>	Current Turn-On Delay Time-Resistive	$V_{CE}$ = 14 V, $R_{L}$ = 1 Ω, $V_{GE}$ = 5 V, $R_{G}$ = 470 Ω, $T_{J}$ = 25°C		-	0.9	4	μs
t <sub>rR</sub>	Current Rise Time-Resistive			-	1.9	7	1
td <sub>(OFF)L</sub>	Current Turn-Off Delay Time-Inductive	$V_{CE} = 300 \text{ V, L} = 1 \text{ mH,} $ $V_{GE} = 5 \text{ V, R}_{G} = 470 \Omega,$		-	4.8	10	1
t <sub>fL</sub>	Current Fall Time-Inductive	I <sub>CE</sub> = 6.5 A, T <sub>J</sub> = 25°C		_	2.0	15	1

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### PACKAGE MARKING AND ORDERING INFORMATION

Device	Package	Shipping <sup>†</sup>
FGD3040G2-F085C	DPAK (Pb-Free)	2500 Units / Tape & Reel
FGB3040G2-F085C	D <sup>2</sup> PAK (Pb-Free)	800 Units / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### TYPICAL CHARACTERISTICS

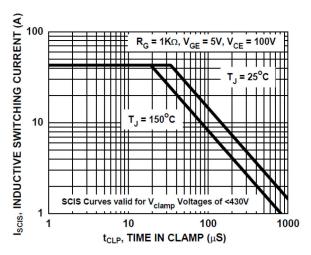


Figure 1. Self Clamped Inductive Switching Current vs. Time in Clamp

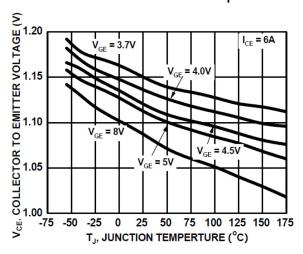


Figure 3. Collector to Emitter On–State Voltage vs. Junction Temperature

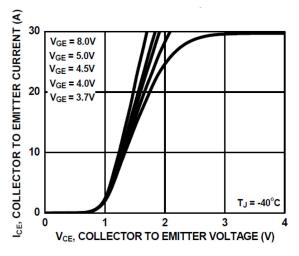


Figure 5. Collector to Emitter On–State Voltage vs. Collector Current

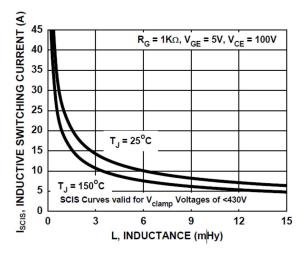


Figure 2. Self Clamped Inductive Switching Current vs. Inductance

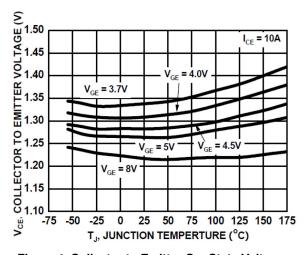


Figure 4. Collector to Emitter On-State Voltage vs. Junction Temperature

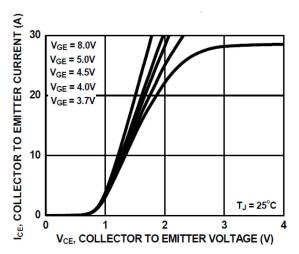


Figure 6. Collector to Emitter On-State Voltage vs. Collector Current

#### TYPICAL CHARACTERISTICS (continued)

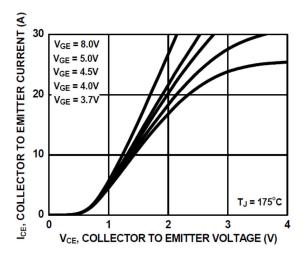


Figure 7. Collector to Emitter On-State Voltage vs. Collector Current

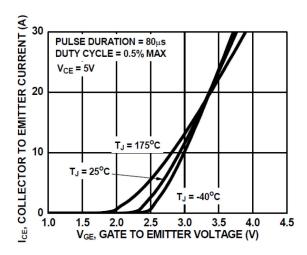


Figure 8. Transfer Characteristics

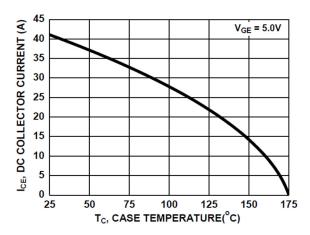


Figure 9. DC Collector Current vs. Case Temperature

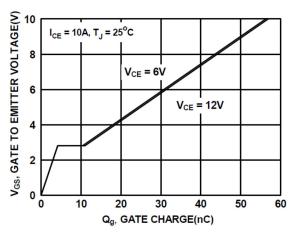


Figure 10. Gate Charge

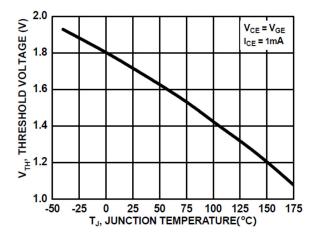


Figure 11. Threshold Voltage vs. Junction Temperature

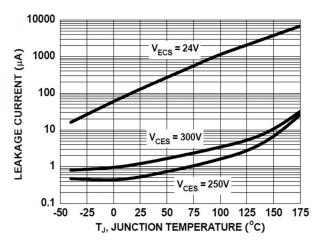
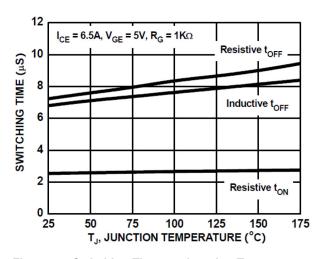


Figure 12. Leakage Current vs. Junction Temperature

## TYPICAL CHARACTERISTICS (continued)



2000 f = 1MHz  $V_{GE} = 0V$ 1600 CAPACITANCE (pF) CIES 1200 800 C<sub>RES</sub> 400 COES 0 5 25 10 15 20 V<sub>DS</sub>, DRAIN TO SOURCE VOLTAGE (V)

Figure 13. Switching Time vs. Junction Temperature

Figure 14. Capacitance vs. Collector to Emitter

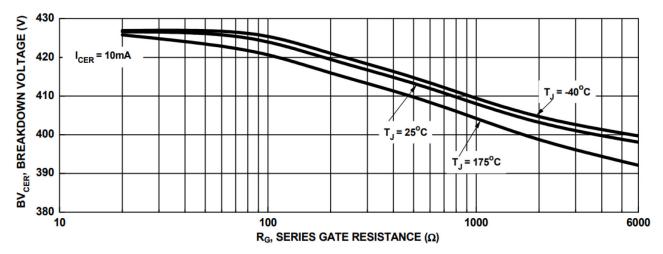


Figure 15. Break Down Voltage vs. Series Resistance

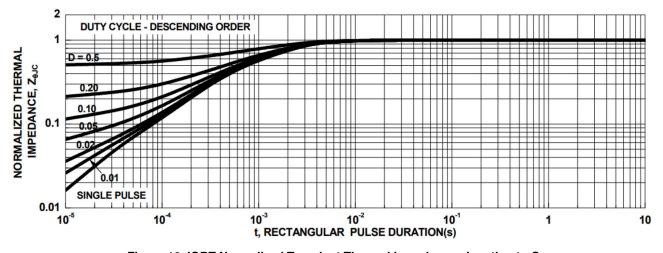
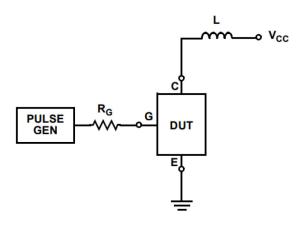


Figure 16. IGBT Normalized Transient Thermal Impedance, Junction to Case

## **TEST CIRCUIT AND WAVEFORMS**



 $R_{G} = 1K\Omega$  DUT  $V_{CC}$ 

Figure 17. Inductive Switching Test Circuit

Figure 18.  $t_{\text{ON}}$  and  $t_{\text{OFF}}$  Switching Test Circuit

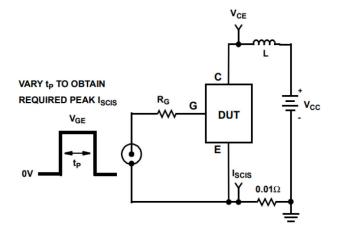


Figure 19. Energy Test Circuit

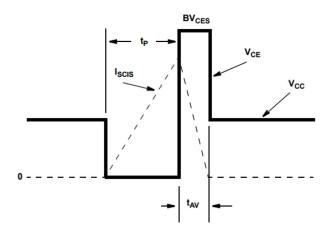


Figure 20. Energy Waveforms





#### DPAK3 6.10x6.54x2.29, 4.57P CASE 369AS **ISSUE B**

**DATE 20 DEC 2023** 

- NOTES: UNLESS OTHERWISE SPECIFIED

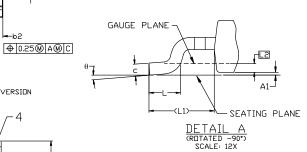
  A) THIS PACKAGE CONFORMS TO JEDEC, TO-252, ISSUE F, VARIATION AA.

  B) ALL DIMENSIONS ARE IN MILLIMETERS.

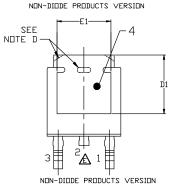
  C) DIMENSIONING AND TOLERANCING PER

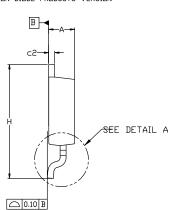
  - D)

- A
- F)
- DIMENSIONING AND TOLERANCING PER
  ASME Y14.5M-2018.
  SUPPLIER DEPENDENT MOLD LOCKING HOLES OR CHAMFERED
  CORNERS OR EDGE PROTRUSION.
  FOR DIODE PRODUCTS, L4 IS 0.25 MM MAX PLASTIC BODY
  STUB WITHOUT CENTER LEAD.
  DIMENSIONS ARE EXCLUSIVE OF BURRS,
  MOLD FLASH AND TIE BAR EXTRUSIONS.
  LAND PATTERN RECOMMENDATION IS BASED ON IPC7351A STD
  T0228P991X239-3N.



millimeters				
DIM	MIN.	NDM.	MAX.	
Α	2.18	2.29	2.39	
A1	0.00	-	0.127	
b	0.64	0.77	0.89	
b2	0.76	0.95	1.14	
b3	5.21	5.34	5.46	
C	0.45	0.53	0.61	
c2	0.45	0.52	0.58	
D	5.97	6.10	6.22	
D1	5.21			
E	6.35	6.54	6.73	
E1	4.32			
е	2.2	286 BS	C	
e1	4.5	572 BS	C	
Н	9.40	9.91	10.41	
L	1.40	1.59	1.78	
L1	2.90 REF			
L2	0.51 BSC			
L3	0.89	1.08	1.27	
L4			1.02	
θ	0°		10°	





5.55	MIN
6.40	6.50 MIN
	2.85 MIN
4.5	1.25 MIN 2.286

#### LAND PATTERN RECOMMENDATION

\*FOR ADDITIONAL INFORMATION ON DUR
PB-FREE STRATEGY AND SOLDERING DETAILS,
PLEASE DOWNLOAD THE ON SEMICONDUCTOR
SOLDERING AND MOUNTING TECHNIQUES
REFERENCE MANUAL, SOLDERRM/D.

#### **GENERIC MARKING DIAGRAM\***

XXXXXX XXXXXX AYWWZZ

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "=", may or may not be present. Some products may not follow the Generic Marking.

XXXX = Specific Device Code

= Assembly Location Α

Υ

WW = Work Week

77 = Assembly Lot Code

I DOCHMENT NUMBER I AGAANII 2010A		Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.	
DESCRIPTION: DPAK3 6 10x6 54x2 29 4 57P		PAGE 1 OF 1	

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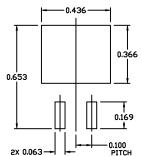




#### **D<sup>2</sup>PAK-3 (TO-263, 3-LEAD)** CASE 418AJ

ISSUE F

**DATE 11 MAR 2021** 



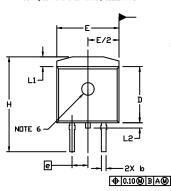
RECOMMENDED
MOUNTING FOOTPRINT

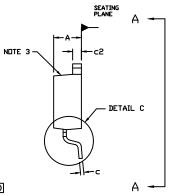
 For additional information on our Pb-Free strategy and soldering details, please downloa the DN Semiconductor Soldering and Mounting Techniques Reference Manual, SDL DERRIV/D.

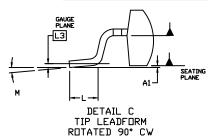
#### NOTES

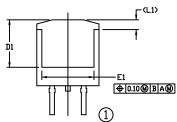
- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: INCHES
- 3. CHAMFER OPTIONAL
- I. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.005 PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE DUTERMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.
- 5. THERMAL PAD CONTOUR IS OPTIONAL WITHIN DIMENSIONS E, L1, D1, AND E1.
- 6. OPTIONAL MOLD FEATURE.
- 7. ①,② ... OPTIONAL CONSTRUCTION FEATURE CALL DUTS.

	INCHES		MILLIMETERS	
DIM	MIN.	MAX.	MIN.	MAX.
A	0.160	0.190	4.06	4.83
A1	0.000	0.010	0.00	0.25
ھ	0.020	0.039	0.51	0.99
u	0.012	0.029	0.30	0.74
52	0.045	0.065	1.14	1.65
D	0.330	0.380	8.38	9.65
D1	0.260		6.60	
E	0.380	0.420	9.65	10.67
E1	0.245	-	6.22	
e	0.100	BSC	2.54 BSC	
Ξ	0.575	0.625	14.60	15.88
L	0.070	0.110	1.78	2.79
L1		0.066		1.68
L2		0.070		1.78
L3	0.010 BSC		0.25 BSC	
М	0*	8*	0*	8*

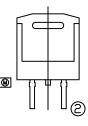


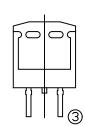


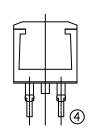




VIEW A-A







VIEW A-A

OPTIONAL CONSTRUCTIONS

## XXXXXX = Specific Device Code

A = Assembly Location

WL = Wafer Lot Y = Year

WW = Work Week

W = Week Code (SSG)

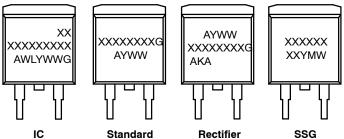
M = Month Code (SSG)

G = Pb-Free Package

AKA = Polarity Indicator

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " •", may or may not be present. Some products may not follow the Generic Marking.

## GENERIC MARKING DIAGRAMS\*



**DOCUMENT NUMBER:** 

98AON56370E

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DESCRIPTION:

D<sup>2</sup>PAK-3 (TO-263, 3-LEAD)

PAGE 1 OF 1

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